

Search Notes

Application/Control No.

10/800,867

Examiner

Nguyen N. Hanh

Applicant(s)/Patent under
Reexamination

TAKENAKA ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	52	3/1/2006	HN
310	54	3/1/2006	HN
310	58	3/1/2006	HN
310	64	3/1/2006	HN
update Search	All	8/25/06	HN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR